STP9N80K5, STW9N80K5



N-channel 800 V, 0.73 Ω typ., 7 A MDmesh $^{\rm TM}$ K5 Power MOSFETs in a TO-220 and TO-247 packages

Datasheet - production data

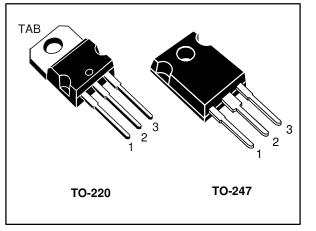
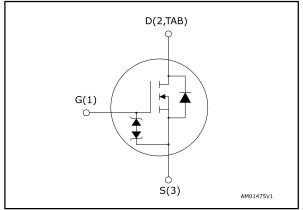


Figure 1: Internal schematic diagram



Features

Order code	V _{DS} R _{DS(on)} max.		ID
STP9N80K5	800 V	0.90 Ω	7 A
STW9N80K5	800 V	0.90 12	7 A

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

These very high voltage N-channel Power MOSFET are designed using MDmesh[™] K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STP9N80K5		TO-220	Tuba
STW9N80K5	9N80K5	TO-247	Tube

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This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vgs	Gate-source voltage	± 30	V
ID	Drain current (continuous) at T _C = 25 °C	7	А
ID	Drain current (continuous) at Tc = 100 °C	4.4	А
ID ⁽¹⁾	Drain current (pulsed)	28	А
Ртот	Total dissipation at $T_C = 25 \text{ °C}$	110	
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4.5	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	
TJ	Operating unction temperature range	EE to 150	°C
T _{stg}	Storage temperature range	- 55 to 150	-C

Notes:

⁽¹⁾Pulse width limited by safe operating area.

 $^{(2)}I_{SD} \leq 7$ A, di/dt
 ≤ 100 A/µs; V_Ds peak < V(BR)DSS,VDD= 640 V $^{(3)}V_{DS} \leq 640$ V

Table 3: Thermal data

Symbol	Parameter	Value		Unit
		TO-220 TO-247		
Rthj-case	Thermal resistance junction-case	1.14		°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	50	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
lar	Avalanche current, repetitive or not repetitive (pulse width limited by Tjmax)	2.4	А
Eas	Single pulse avalanche energy (starting Tj = 25 °C, I_D = I_{AR}, V_{DD} = 50 V)	200	mJ



2 Electrical characteristics

 $T_C = 25$ °C unless otherwise specified

Table 5: On/oπ-state						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 1 mA$	800			V
		$V_{GS} = 0 V, V_{DS} = 800 V$			1	μA
IDSS	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 800 V$ T _c = 125 °C ⁽¹⁾			50	μA
I _{GSS}	Gate body leakage current	$V_{\text{DS}} = 0 \ V, \ V_{\text{GS}} = \pm 20 \ V$			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 100 \ \mu\text{A}$	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	V_{GS} = 10 V, I_{D} = 3.5 A		0.73	0.90	Ω

Table 5: On/off-state

Notes:

⁽¹⁾Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		I	340	-	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	37	-	pF
Crss	Reverse transfer capacitance		I	0.65	-	pF
Co(tr) ⁽¹⁾	Equivalent capacitance time related	V _{GS} = 0 V, V _{DS} = 0 to 640 V	-	61	-	pF
$C_{o(er)}^{(2)}$	Equivalent capacitance energy related	$\mathbf{v}_{\mathrm{GS}} = 0 \mathbf{v}, \mathbf{v}_{\mathrm{DS}} = 0 0 0 0 0 \mathbf{v}$		22		pF
Rg	Intrinsic gate resistance	f = 1 MHz open drain	-	7	-	Ω
Qg	Total gate charge	$V_{DD} = 640 \text{ V}, \text{ I}_{D} = 7 \text{ A}$	-	12	-	nC
Qgs	Gate-source charge	V _{GS} = 10 V	-	3.8	-	nC
Q _{gd}	Gate-drain charge	See (Figure 16: "Test circuit for gate charge behavior")	-	6.7	-	nC

Table 6: Dynamic

Notes:

 $^{(1)}C_{0(tr)}$ is a constant capacitance value that gives the same charging time as Coss while V_{DS} is rising from 0 to 80% $V_{DSS}.$

 $^{(2)}C_{0(er)}$ is a constant capacitance value that gives the same stored energy as Coss while V_{DS} is rising from 0 to 80% $V_{DSS}.$

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{\text{DD}}\text{=}$ 400 V, I_{D} =3.5 A, R_{G} = 4.7 Ω	-	11	-	ns
tr	Rise time	V _{GS} = 10 V	-	5.7	-	ns
td(off)	Turn-off delay time	See (Figure 15: "Test circuit for resistive load switching times" and	-	65.3	-	ns
t _f	Fall time	Figure 20: "Switching time waveform")	-	13.6	-	ns

Table 7: Switching times

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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isd	Source-drain current		-		7	А
Isdm ⁽¹⁾	Source-drain current (pulsed)		-		28	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 7 \text{ A}, V_{GS} = 0 \text{ V}$	-		1.5	V
trr	Reverse recovery time	I _{SD} = 7 A, di/dt = 100 A/μs,	-	292		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V See <i>Figure 17: "Test circuit for</i>	-	2.66		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times"	-	18.2		А
t _{rr}	Reverse recovery time	I _{SD} = 7 A, di/dt = 100 A/μs	-	477		ns
Qrr	Reverse recovery charge	$V_{DD} = 60$ V, $T_j = 150$ °C See <i>Figure 17: "Test circuit for</i>	-	3.91		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times"	-	16.4		А

Table 8: Source-drain diode

Notes:

 $\ensuremath{^{(1)}}\ensuremath{\mathsf{Pulse}}$ width limited by safe operating area

 $^{(2)}$ Pulsed: pulse duration = 300 µs, duty cycle 1.5%

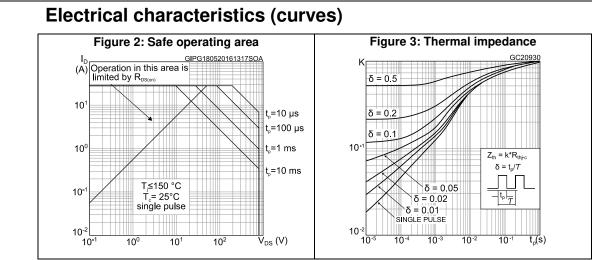
Table 9: Gate-source Zener diode

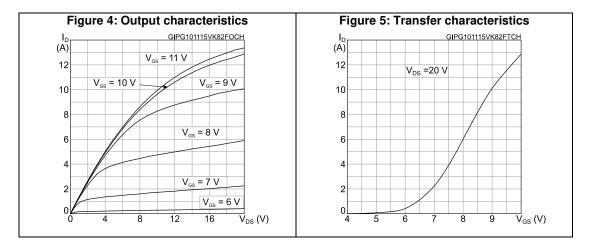
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V(BR)GSO	Gate-source breakdown voltage	I _{GS} = ± 1mA,I _D = 0 A	30	-	-	V

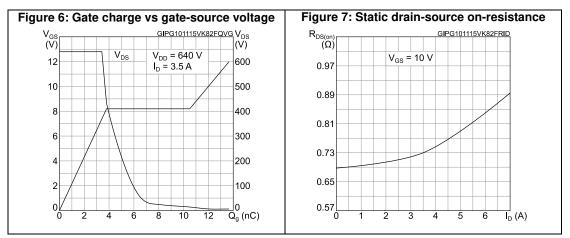
The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



2.1



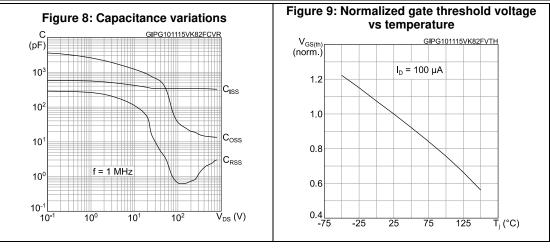


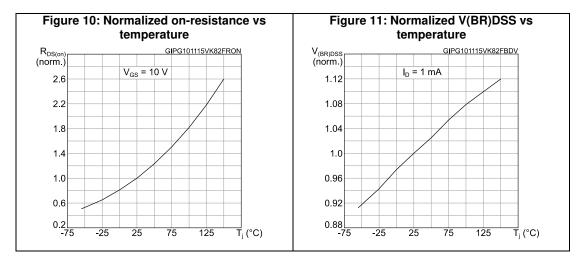


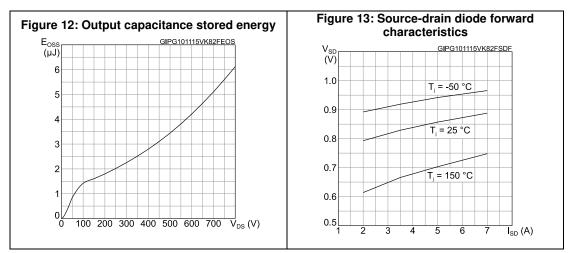




Electrical characteristics





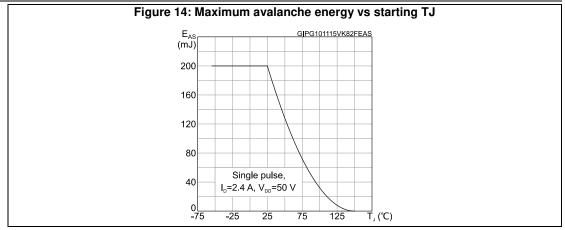


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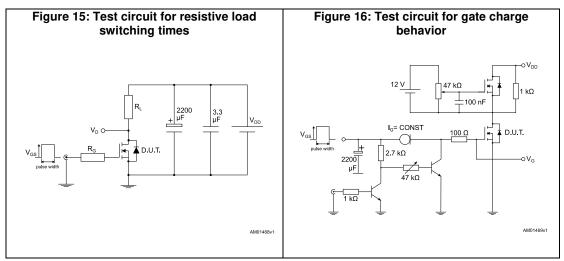
Electrical characteristics

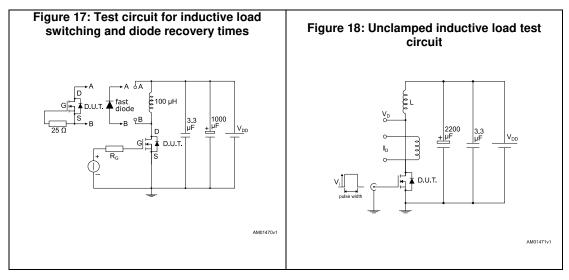
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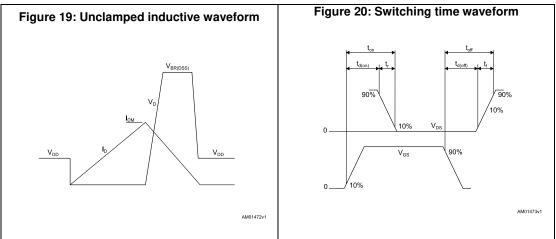




3 Test circuits







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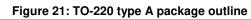
4 Package information

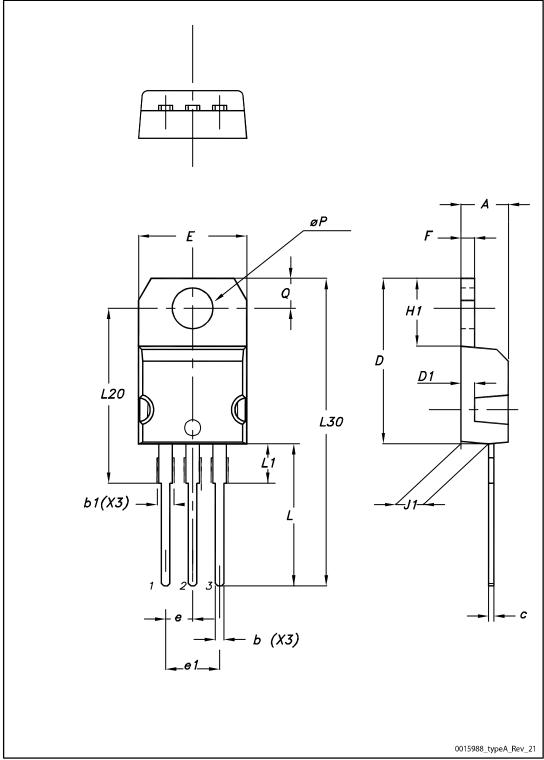
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



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4.1 TO-220 type A package information





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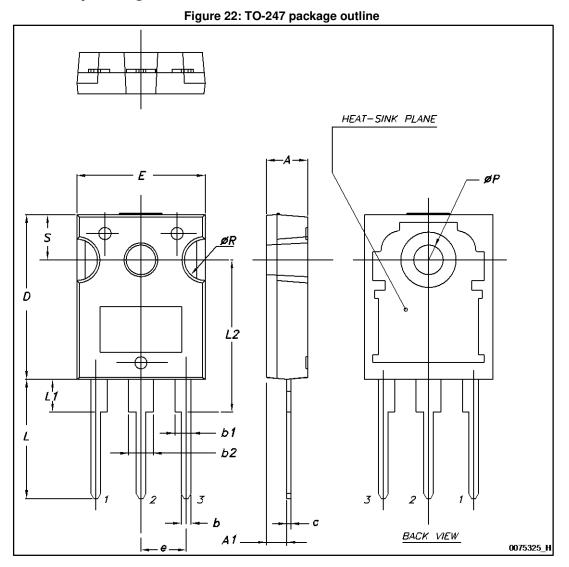
Package information

STP9N80K5, STW9N80K5

formation STP9N80K5, STW9N80K5					
	Table 10: TO-220 ty	pe A mechanical data			
Dim		mm			
Dim.	Min.	Тур.	Max.		
A	4.40		4.60		
b	0.61		0.88		
b1	1.14		1.55		
С	0.48		0.70		
D	15.25		15.75		
D1		1.27			
E	10.00		10.40		
е	2.40		2.70		
e1	4.95		5.15		
F	1.23		1.32		
H1	6.20		6.60		
J1	2.40		2.72		
L	13.00		14.00		
L1	3.50		3.93		
L20		16.40			
L30		28.90			
øP	3.75		3.85		
Q	2.65		2.95		



4.2 TO-247 package information





Package information

ormation		STP	9N80K5, STW9N80K	
Table 11: TO-247 package mechanical data				
Dim.	mm			
	Min.	Тур.	Max.	
А	4.85		5.15	
A1	2.20		2.60	
b	1.0		1.40	
b1	2.0		2.40	
b2	3.0		3.40	
С	0.40		0.80	
D	19.85		20.15	
E	15.45		15.75	
е	5.30	5.45	5.60	
L	14.20		14.80	
L1	3.70		4.30	
L2		18.50		
ØP	3.55		3.65	
ØR	4.50		5.50	
S	5.30	5.50	5.70	



5 Revision history

Table 12: Document revision history

Date	Revision	Changes
13-Oct-2015	1	First release.
20-May-2016	Modified: <i>Table 4: "Avalanche characteristics", Table 6: "Dynam Table 7: "Switching times"</i> and <i>Table 8: "Source-drain diode".</i> Minor text changes	
26-Jul-2016	3	Updated features in cover page.



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